

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/719,171	PROPP ET AL.	
Examiner	Art Unit	
Victor X. Nguyen	3734	

SEARCHED				
Class	Subclass	Date	Examiner	
600	564	11/7/2005	VN	
604	22,174	10	"	
606	205,206	10	"	
	207,208	11	II .	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventors searched	11/7/2005	VN		
Text/East searched	11	/1		